

<i>Notice of References Cited</i>	Application/Control No. 10/526,020	Applicant(s)/Patent Under Reexamination MIYAMOTO ET AL.	
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*	B	US-2001/0009741	07-2001	DURKOT et al.	429/229
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	E	US-			
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	M	US-			

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NON-PATENT DOCUMENTS

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	U	
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